


<b>Search Notes</b>  	<b>Application/Control No.</b>  10551933	<b>Applicant(s)/Patent Under Reexamination</b>  ALI ET AL.
	<b>Examiner</b>  Loewe, Sun Jae Y	<b>Art Unit</b>  1626

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
sTN structure	7/10/2007	sl
palm inventor (all inventors)	7/10/2007	sl
stn updated structure search	11-28-2007	sl
palm updated inventor search (all inventors)	11-28-2007	sl
STN: registry & caplus updated	4-28-2008	sl
PALM updated search all inventors	4-28-2008	sl
STN: registry & caplus updated	1-4-2008	sl
PALM all inventors updated	1-4-2008	sl

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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